§2. Dielectronic Recombination Rate Coefficients to the Excited States of C II from C III

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In order to estimate the line emission of carbon ions in a plasma, we have to know the population of the excited states. The populations of the excited states are determined mainly by the excitation from the ground state and the recombination from the ions in low density plasmas. In the case of a recombining plasma, the recombination to each excited state is necessary to estimate the line emissions. These data are also necessary to obtain the effective recombination rate coefficients at high electron densities. The effective ionization and recombination rate coefficients are important to determine the ion abundances in high density plasmas. There are several calculations of the total dielectronic recombination, but there are no data for the excited states. We tried to calculate the data for CI¹⁾.In this paper we calculate the dielectronic recombination rate coefficients to the excited states of CII using Cowan's program.

We have considered the following transitions as the dielectronic recombination processes.

a)
$$\alpha_d (1s^2 2s 2p^2 (^2P))$$

The main dielectronic recombination process is, $1s^22s^2$ (¹S) + e -> 2s 2p nl (^{2S+1}L)

-> 2s 2p² (^{2S+1} L).
b)
$$\alpha_d$$
 (1s² 2p³ (^{2S+1} L))

The main dielectronic recombination process is, $1s^{2}2s^{2}$ (¹S) + e -> $1s^{2}2p^{2}$ nl (^{2S+1}L) --> $1s^{2}2p^{3}$ (^{2S+1}L'). c) α_{d} ($1s^{2}2s^{2}$ nl (^{2S+1}L))

The dielectronic recombination process is, $2s^2 + e \rightarrow 2s 2p nl (^{2S+1}L)$ $-> 2s^2 nl (^{2S+1}L').$ With the use of the atomic data of dielectronic

With the use of the atomic data of dielectronic recombination processes (energy levels, radiative transition probability and autoionization rate) for the levels with the principal quantum number n = 2

- 6 of C II, the dielectronic recombination rate coefficients from C III $(2s^2)$ to the excited states are calculated. Autoionizing levels above three thresholds: $1s^22s^2$ (¹S), $1s^2 2s2p({}^{3}P, {}^{1}P)$ were considered. We have found the DR rate on $2s2p^2$ levels are very large at low temperature as shown in Fig. 1. These have not been reported. The rate coefficients are fitted to an analytical formula and the fit parameters are given. The values for higher excited states than n = 6 are extrapolated and the total dielectronic recombination rate coefficient are derived.

We have derived the effective recombination rate coefficients as a function of the electron density and the electron temperature by a collisional radiative model of CII.

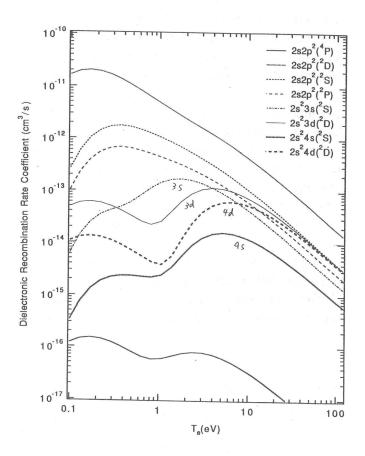


Fig. 1 The dielectronic recombination rate coefficients to excited states of C II.

Reference

1) J. Dubau and T. Kato, NIFS-DATA-21 (1994)